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# CrystalPlan: an Experiment Planning Tool for Crystallography

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Beam time at large x-ray and neutron scattering facilities is always at a premium. The CrystalPlan program can calculate the data coverage of a crystal in reciprocal space in a single-crystal diffraction time-of-flight experiment. CrystalPlan can help a user build an experiment plan that will acquire the most data possible, with sufficient coverage but limited redundancy, therefore increasing scientific productivity. An attractive GUI including a 3D viewer and an automated coverage optimizer are among its useful features. A sample use case of the program with the TOPAZ beamline at SNS will be presented.

### 1. Section title

### 1.1. Title

# Appendix A Appendix title

## A.1. Title

Acknowledgements

### References

Author, A. & Author, B. (1984). Journal Vol, first page-last page.

Table 1
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# Figure 1

Caption describing figure.